CRMPEL1036A

P-Channel -100V, 37mΩ Typ. Power MOSFET

Description

Features

• -100V, -7A

 $R_{DS(ON)}$ Typ = 37m Ω @ V_{GS} = -10V

 $R_{DS(ON)}$ Typ = $48m\Omega$ @ V_{GS} = -4.5V

- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free

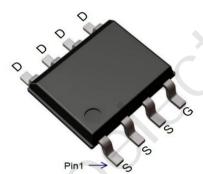
• 100% UIS TESTED!

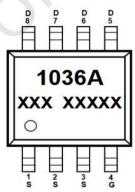


Schematic Diagram

Application

- Load Switch
- PWM Application
- Power Management





Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMPEL1036A	1036A	SOP-8	TAPING	13"	4000	40000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		-100	V
V _{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	T _A = 25°C	-7	А
I _D		T _A = 100°C	-4.2	А
I _{DM}	Pulsed Drain Current (1)		-28	А
E _{AS}	Single Pulsed Avalanche Energy (2)		116	mJ
P_{D}	Power Dissipation	T _A = 25°C	4.2	W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambien	t ⁽³⁾	30	°C/W
T_{J} , T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C

CRMPEL1036A

P-Channel -100V, 37mΩ Typ. Power MOSFET

Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Uni
Off Chara	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -80V, V_{GS} = 0V$	-	-	-1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.4	-2	-2.6	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = -10V, I_D = -5A$	-	37	48	mΩ
		$V_{GS} = -4.5V, I_{D} = -3A$	-	48	62	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		-(1230	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = -50V,$ f = 1MHz	X-\	246	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 11VII 12	-	15	-	pF
Q_g	Total Gate Charge		J .	19	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to -10V}$ $V_{DS} = -50V, I_{D} = -5A$	-	7	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = -50 V, I _D = -5A	-	4	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime	.()	-	12	-	ns
t _r	Turn-On Rise Time	$V_{GS} = -10V, V_{DD} = -50V$	-	55	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	I_D = -5A, R_{GEN} = 6Ω	-	40	-	ns
$t_{\rm f}$	Turn-Off Fall Time		-	75	-	ns
Drain-So	urce Diode Characteristics and M	lax Ratings				
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	-7	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-28	Α
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = -5A$	-	-	-1.2	V
trr	Body Diode Reverse Recovery Time	I - EA di/dt - 400A/:	-	50	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = -5A$, di/dt = 100A/us	-	125	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =-50V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =-21.5A

^{3.} $R_{\scriptscriptstyle \theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{4.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

P-Channel -100V, 37mΩ Typ. Power MOSFET

Test Circuit

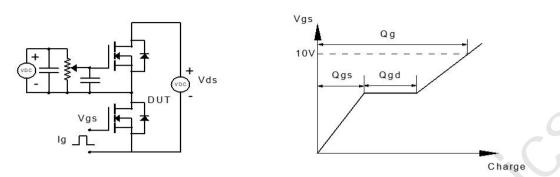


Figure 1: Gate Charge Test Circuit & Waveform

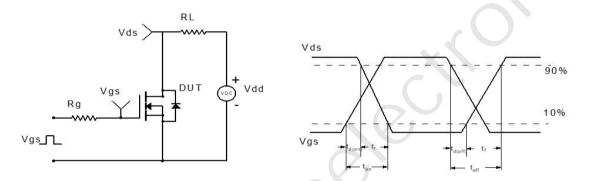


Figure 2: Resistive Switching Test Circuit & Waveform

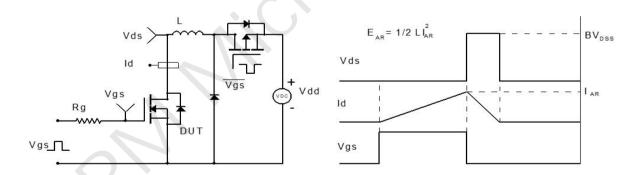


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

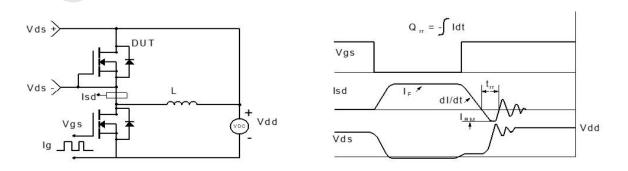
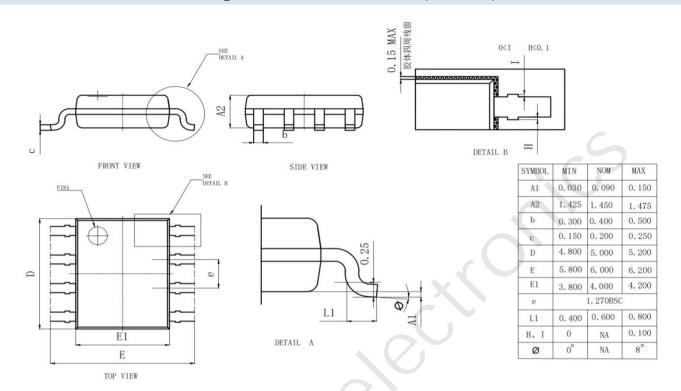


Figure 4: Diode Recovery Test Circuit & Waveform

CRMPEL1036A

P-Channel -100V, 37mΩ Typ. Power MOSFET

Package Mechanical Data(SOP-8)



Important Notice

The information presented in datasheets is for reference only. CRM reserves the right to make changes at any time to any products or information herein, without notice.

Customers are responsible for the design and applications, including compliance with all laws, regulations and safety requirements or standards.

"Typical" parameters which provided in datasheets can vary in different applications and actual performance may vary over time. Customers are responsible for doing all necessary testing to minimize the risks associated with their applications and products.

is a registered trademark of Wuxi CRM Microelectronics Co., Ltd. Copyright ©2023 CRM Microelectronics Co., Ltd. All rights reserved.

Contact information

For more information, please visit: http://www.crm-semi.tech For sales information, please send an email to: sales@crm-semi.com